

Supporting information

Manipulating the Phase Transformation Temperature to Achieve Cubic

Cu₅FeS_{4-x}Se_x and Enhanced Thermoelectric Performance

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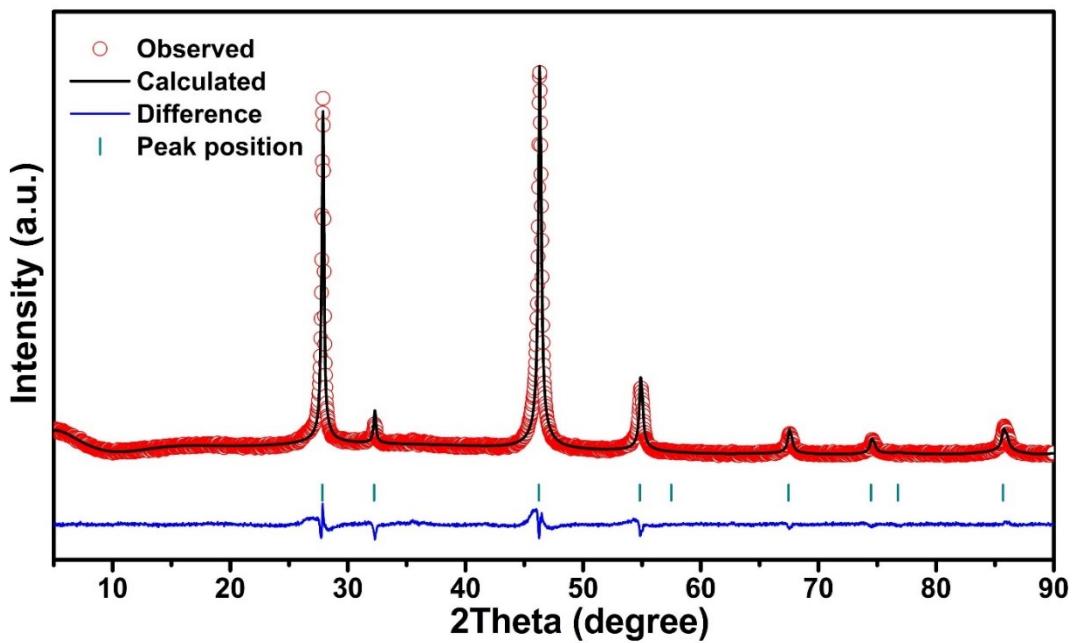


Fig. S1 Experimental XRD pattern of the $\text{Cu}_5\text{FeS}_2\text{Se}_2$ sample and the corresponding results of Rietveld refinement. The low values of R_{wp} (2.12%) and R_p (1.37%) indicate the reliability of the refinement. The XRD pattern can be indexed to the high cubic bornite phase.

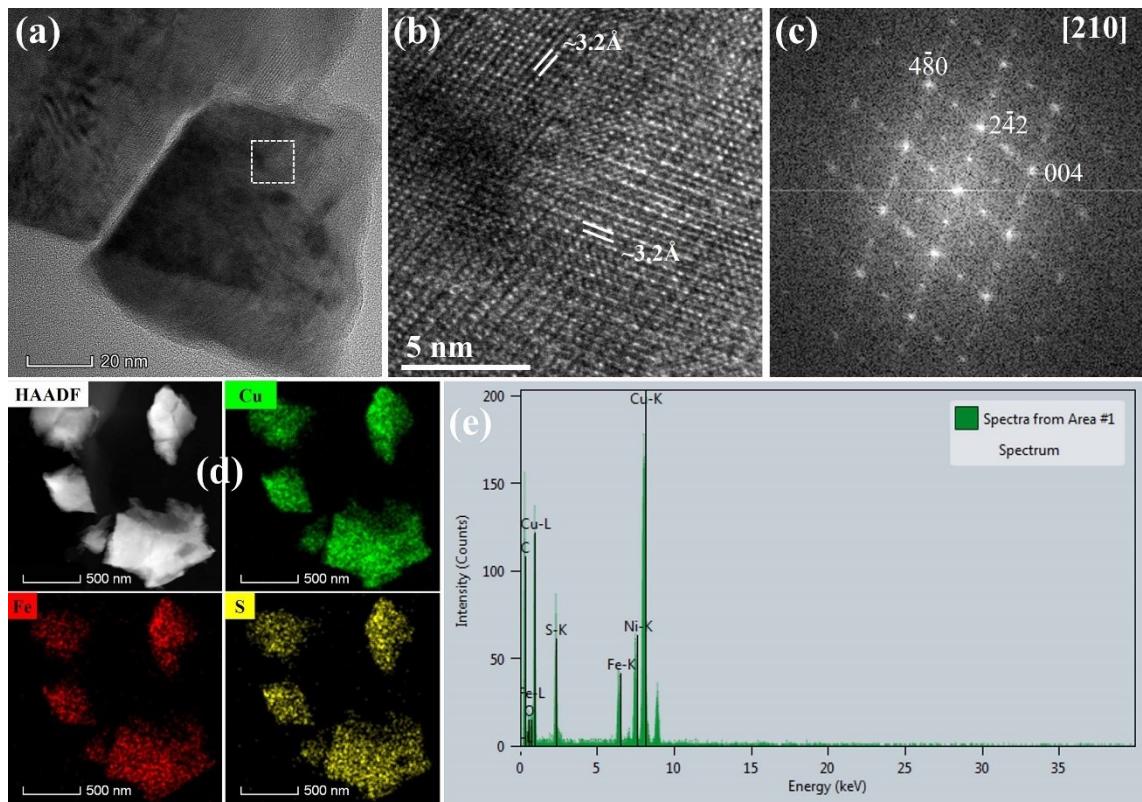


Fig. S2 Electron microscopy characterization of Cu_5FeS_4 : (a) TEM image, (b) HRTEM image of the marked region in (b) and (c) the corresponding FFT pattern, (d) HAADF image and EDS elemental mapping of Cu, Fe and S, (e) EDS spectrum.

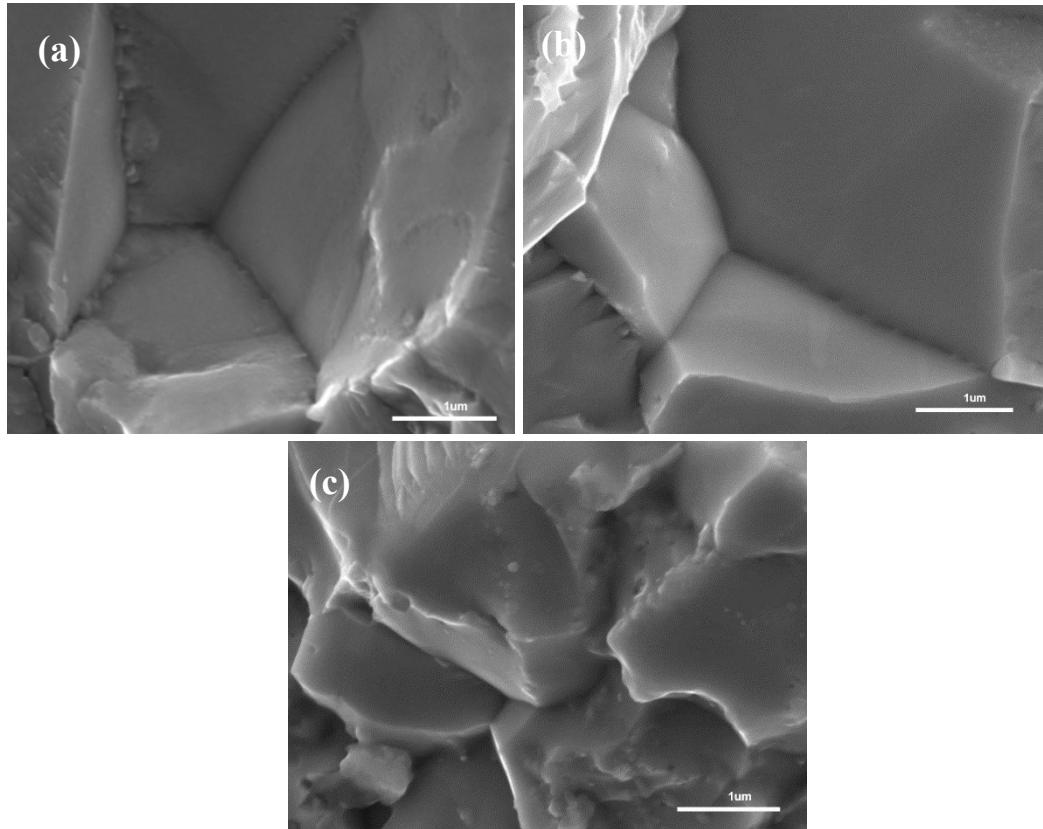


Fig. S3 SEM images of sintered $\text{Cu}_5\text{FeS}_{4-x}\text{S}_x$: (a) $x = 0$, (b) $x = 0.4$, (c) $x = 2.0$. The sintered samples are composed of micrometer-sized particles.

Fig. S4 (a) UV-vis absorption spectra, (b) $(\alpha h\nu)^2$ vs photon energy plots for $\text{Cu}_5\text{FeS}_{4-x}\text{Se}_x$ ($x = 0, 0.4, 0.8, 1.5, 2.0$) at room temperature.

Fig. S5 Calculated Seebeck-Normalized conductivity ($|S|-\sigma/\sigma_{E0}$) relation assuming (a) acoustic phonon scattering, and (b) ionization scattering dominant charge carrier transport. The σ_{E0} could be extracted from a pair of experimentally measured S and σ at the same temperature.

Table S1. A summary of thermoelectric properties of Cu₅FeS₄ based materials

Materials	<i>T</i> ^{a)} [K]	<i>zT</i> ^{b)}	<i>S²σ</i> ^{b)} [mW m ⁻¹ K ⁻²]	Synthesis method	References
Cu ₅ FeS ₄	735	0.49	0.31	Melting + annealing + SPS	This work
Cu ₅ FeS _{3.6} Se _{0.4}	735	0.60	0.39	Melting + annealing + SPS	This work
Cu ₅ FeS _{3.2} Se _{0.8}	735	0.57	0.42	Melting + annealing + SPS	This work
Cu ₅ FeS _{2.5} Se _{1.5}	735	0.56	0.56	Melting + annealing + SPS	This work
Cu ₅ FeS _{2.0} Se _{2.0}	735	0.54	0.56	Melting + annealing + SPS	This work
Cu ₅ FeS ₄	700	~0.38	~0.25	Melting + annealing + SPS	¹
Cu _{5.04} Fe _{0.96} S ₄	700	0.52	~0.35	Melting + annealing + SPS	¹
Cu ₅ FeS ₄	710	0.62	0.39	Colloidal synthesis + SPS	²
Cu ₅ FeS ₄	690	0.56	0.4	Colloidal synthesis + SPS	³
Cu ₅ Fe _{0.95} Mn _{0.05} S ₄	543	0.55	0.34	Ball milling + hot pressing	⁴
Cu ₅ FeS _{3.8} Se _{0.2}	540	0.5	0.43	Ball milling + SPS	⁵
Cu ₅ FeS _{3.8} Se _{0.2}	670	~0.59	~0.41	Ball milling + SPS	⁵
Cu ₅ FeS _{3.6} Se _{0.4}	670	~0.66	~0.52	Ball milling + SPS	⁵
Cu _{4.972} Fe _{0.968} S ₄	550	0.79	~0.44	Ball milling + hot pressing	⁶
Cu _{4.96} Co _{0.04} FeS ₄	590	~0.5	~0.30	Ball milling + hot pressing	⁷
Cu ₅ FeS ₄	593	0.28	0.24	Ball milling + sintering	⁸
Cu _{4.96} Co _{0.04} Fe _{0.96} Zn _{0.04} S ₄	590	0.6	0.37	Ball milling + hot pressing	⁹
Cu ₅ FeS ₄ nanocomposite	663	0.55	~0.56	Chemical synthesis + particle blending + pulse electric current sintering	¹⁰

^{a)}The temperature at which maximum *zT* was achieved; ^{b)}*zT* and *S²σ* at *T*.

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